TOSHIBA



TLCS-870 Series

TMP87PH46NG



Semiconductor Company

Document Change Notification

The purpose of this notification is to inform customers about the launch of the Pb free version of the device. The introduction of a Pb-free replacement affects the datasheet. Please understand that this notification is intended as a temporary substitute for a revision of the datasheet.

Changes to the datasheet may include the following, though not all of them may apply to this particular device.

1. Part number

Example: TMPxxxxxxFG TMPxxxxxxFG

All references to the previous part number were left unchanged in body text. The new part number is indicated on the prelims pages (cover page and this notification).

2. Package code and package dimensions

Example: LQFP100-P-1414-0.50C

LQFP100-P-1414-0.50F

All references to the previous package code and package dimensions were left unchanged in body text. The new ones are indicated on the prelims pages.

3. Addition of notes on lead solderability

Now that the device is Pb free, notes on lead solderability have been added.

Ι

4. RESTRICTIONS ON PRODUCT USE

The previous (obsolete) provision might be left unchanged on page 1 of body text. A new replacement is included on the next page.

5. Publication date of the datasheet

The publication date at the lower right corner of the prelims pages applies to the new device.

1. Part number

2. Package code and dimensions

Previous Part Number (in Body Text)	Previous Package Code (in Body Text)	New Part Number	New Package Code	ОТР
TMP87PH46N	SDIP42-P-600-1.78	TMP87PH46NG	SDIP42-P-600-1.78	_

^{*:} For the dimensions of the new package, see the attached Package Dimensions diagram.

3. Addition of notes on lead solderability

The following solderability test is conducted on the new device

Lead solderability of Pb-free devices (with the G suffix)

Test	Test Conditions	Remark
Solderability	(1) Use of Lead (Pb) -solder bath temperature = 230°C -dipping time = 5 seconds -the number of times = once -use of R-type flux (2) Use of Lead (Pb)-Free -solder bath temperature = 245°C -dipping time = 5 seconds -the number of times = once -use of R-type flux	Leads with over 95% solder coverage till lead forming are acceptable.

4. RESTRICTIONS ON PRODUCT USE

The following replaces the "RESTRICTIONS ON PRODUCT USE" on page 1 of body text.

RESTRICTIONS ON PRODUCT USE

20070701-EN

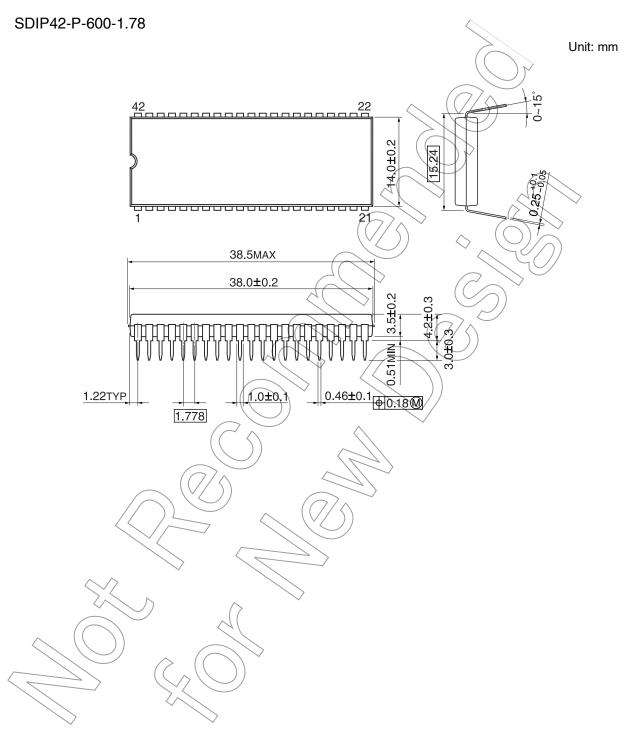
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- For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance/Handling Precautions.

5. Publication date of the datasheet

The publication date of this datasheet is printed at the lower right corner of this notification.

(Annex)

Package Dimensions



III 2008-03-06

CMOS 8-Bit Microcontroller

TMP87PH46N

The 87PH46 is a One-Time PROM microcontroller with low-power 128 K bits (16 Kbytes) electrically programmable read only memory for the 87C446/846/H46 system evaluation. The 87RH46 is pin compatible with the 87C446/846/H46. The operations possible with the 87C446/846/H46 can be performed by writing programs to PROM. The 87PH46 can write and verify in the same way as the TMM27256AD using an adaptor socket BM1193 and an EPROM programmer.

Package

DVIV1

	Part No	OIP	RAIVI	Package (Adaptor socket	
	TMP87PH46N	16 K × 8-bit	512 × 8-bit	P-SDIP42-600-1.78	◯	
Pin Assignn	nents (Top Viev	w)				
P-SDIP42-600-1.	78		\neg	R-SDIP4:	2-600-1.78	
	(HSO) P77 <> □1		12 □		~~~	
	(HSCK) P76 ←> □ 2		11 □ ←→ P22			
	3 / (SO) P75 ←> 3		10 → P21			
	12 / (SI) P74 <> 4		39 2 < > ₽20	'		
	/(SCK) P73 ←→ 5		38 2 × P 17			
	√PWM) P72 ←> 6		37 P16			
	((INT4) P71 <> □ 7		86□ < > P15		Allin.	
A8/(INT	T3/TC3) P70 ←→ 8		35 0 × P14		TMP87PH46N	
	D7/P07 ←> □ 9		34 1 ← P13			
	D6/P06 ←→ □ 10	/ /	P12			
	D5/P05 ←>□ 11	\ \	32 → P11			
	D4/P04 ←→ 12		3111 ≮ ➤ P10 €	~		
	D3/P03 ←>□ 13	////	30□ < > P67			
	D2/P02 - 14	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	29	~ \ \ \		
	D1/P01 ←> □ 15		28			
	D0/P00 ←>□ 16		27 - P64	_ / / /		
	VPP/TEST → □ 17 RESET → □ 18	\ \ / / / / /	26□ ← ➤ P63	_ /		
			25	/ / \		
	XIN → □ 19 XOUT ← □ 20		24] < > P61 23] < > P60	. / . /		
GND/	(VASS) VSS 21		22 VAR			

The information contained herein is subject to change without notice.

Part No.

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 For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance/Handling Precautions.

87PH46-1 2003-09-17

Adaptor socket

Pin Function

The 87PH46 has two modes: MCU and PROM.

(1) MCU mode
In this mode, the 87PH46 is pin compatible with the 87C446/846/H46L (fix the TEST pin at low level).

(2) PROM mode

Din Nama (DDOM mada)	Innut/Outnut	Eurotions	Din Nama (MCII mada)
Pin Name (PROM mode)	Input/Output	Functions	Pin Name (MCU mode)
A14 to A8			P76 to P70
A7 to A0	Input	PROM address inputs	R67 to P60
D7 to D0	I/O	PROM data input/outputs	P07 to P00
CE	la monte	Chip enable signal input (active low)	P13
OE	Input	Output enable signal input (active low)	P14
VPP		+ 12.5 V / 5 V (Program supply voltage)	TEST
vcc	Power supply	+5V	VDD
GND		ov (V)	VSS
P11			
P21		PROM mode setting pins. Be fixed at high level.	
P77			
P12 , P10	1/0		
P17 to P15		DDOM made and a law law law law law law law law law l	
P22 , P20		PROM mode setting pins. Be fixed at low level.	
RESET			
XIN	Input		
хоит	Qutput	Connect an 8MHz oscillator to stabilize the internal sta	ate.
VAREF			
VASS	Power Supply	0 V (GND)	

Operational Description

The following explains the 87PH46 hardware configuration and operation. The configuration and functions of the 87PH46 are the same as those of the 87C446/846/H46, except in that a one-time PROM is used instead of an on-chip mask ROM.

The 87PH46 is placed in the single-clock mode during reset. To use the dual-clock mode, the low-frequency oscillator should be turned on by executing [SET (SYSCR2). XTEN] instruction at the beginning of the program.

1. Operating Mode

The 87PH46 has two modes: MCU and PROM.

1.1 MCU Mode

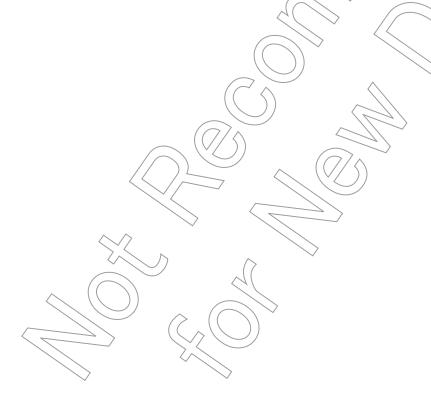
The MCU mode is activated by fixing the TEST / VPP pin at low level.

In the MCU mode, operation is the same as with the 87C446/846/H46 (the TEST / VPP pin cannot be used open because it has no built-in pull-down resistance).

1.1.1 Program Memory

The 87PH46 has a 16 K × 8-bit (addresses C000_H to FFFF_H in the MCU mode, addresses 4000_H to 7FFF_H in the PROM mode) of program memory (OTP).

To use the PH46 as the system evaluation for the 87C446/846/H46, the program should be written to the program memory area as shown in Figure 1-1.



87PH46-3 2003-09-17

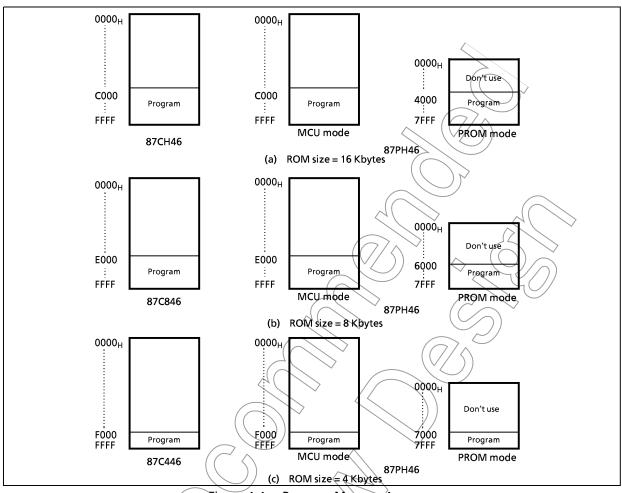


Figure 1-1. Program Memory Area

Note: Either write the data FFH to the unused area or set the PROM programmer to access only the program storage area.

1.1.2 Data Memory

The 87PH46 has an on-chip 512 x 8-bit data memory (static RAM).

1.1.3 Input/Output Circuitry

(1) Control pins

The control pins of the 87PH46 is the same as those of the 87C446/846/H46 except that the TEST pin has is no built-in pull-down resistance.

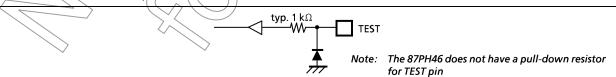


Figure 1-2. TEST Pin

(2) I/O ports

The I/O circuitries of 87PH46 I/O ports the are the same as the code A type I/O circuitries of the 87C446/846/H46.

1.2 PROM Mode

The PROM mode is activated by setting the TEST, RESET pin and the ports P17-P10, P22-P20 and P77 as shown in Figure 1-3. The PROM mode is used to write and verify programs with a general-purpose PROM programmer. The high-speed programming mode can be used for program operation. The 87PH46 is not supported an *electric signature* mode, so the ROM type must be set to TC57256AD. Set the adaptor socket switch to "N".

Note: Please set the high-speed programming mode according to each manual of PROM programmer.

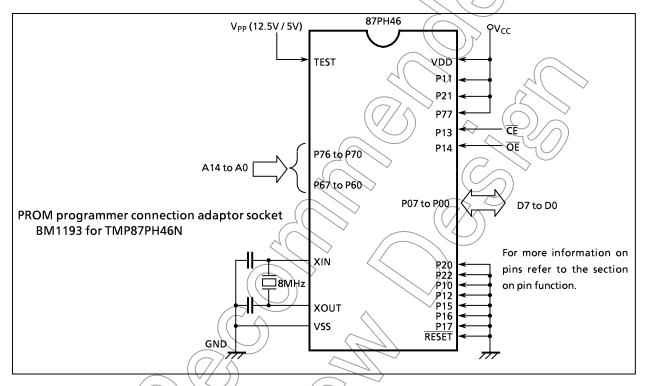


Figure 1-3. Setting for RROM Mode

1.2.1 Programming Flowchart (High-speed Programming Mode-I)

The high-speed programming mode is achieved by applying the program voltage (\pm 12.5 V) to the Vpp pin when Vcc = 6 V. After the address and input data are stable, the data is programmed by applying a single 1ms program pulse to the $\overline{\text{CE}}$ input. The programmed data is verified. If incorrect, another 1ms program pulse is applied and then the programmed data is verified. This process should be repeated (up to 25 times) until the program operates correctly. Programming for one address is ended by applying additional program pulse with width 3 times that needed for initial programming (number of programmed times \times 1 ms). After that, change the address and input data, and program as before. When programming has been completed, the data in all addresses should be verified with Vcc = Vpp = 5 V.

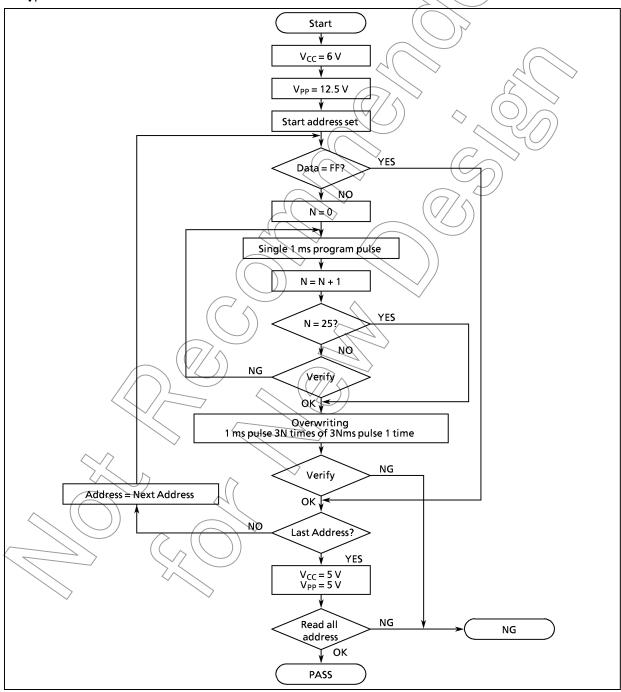


Figure 1-4. Flowchart of High-speed Programming Mode - I

1.2.2 Programming Flowchart (High-speed Programming Mode-II)

The high-speed programming mode is achieved by applying the program voltage (\pm 12.75 V) to the Vpp pin when Vcc = 6.25 V. After the address and input data are stable, the data is programmed by applying a single 0.1ms program pulse to the $\overline{\text{CE}}$ input. The programmed data is verified. If incorrect, another 0.1ms program pulse is applied and then the programmed data is verified. This process should be repeated (up to 25 times) until the program operates correctly. After that, change the address and input data, and program as before. When programming has been completed, the data in all addresses should be verified with Vcc = Vpp = 5 V.

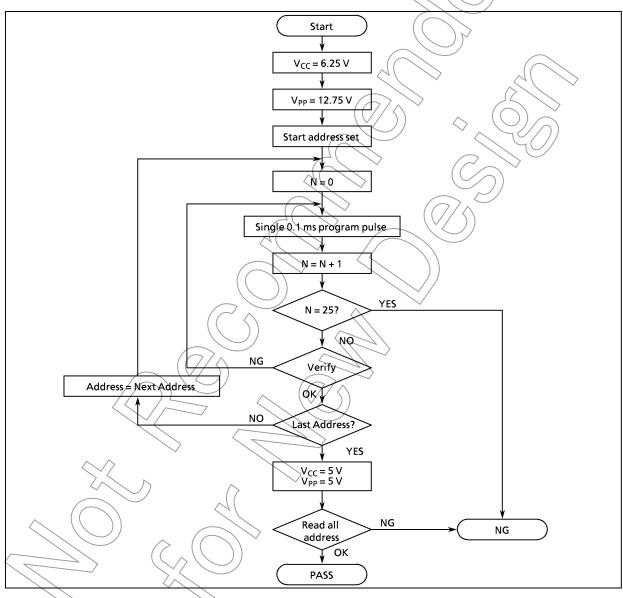


Figure 1-5. Flowchart of High-speed Programming Mode - II

1.2.3 Writing Method for General-purpose PROM Program

(1) Adapters

BM1193: TMP87PH46N

(2) Adapter setting Switch (SW1) is set to side N.

(3) PROM programmer specifying

i) PROM type is specified to TC57256AD.

Writing voltage: 12.5 V (high-speed program I mode) \ 12.75 V (high-speed program II mode)

ii) Data transfer (copy) (note 1)

In TMP87PH46, EPROM is within the addresses 4000 to 7FFFH. Data is required to be transferred (copied) to the addresses where it is possible to write. The program area in MCU mode and PROM mode is referred to "Program memory area" in figure 1-1.

Ex. In the block transfer (copy) mode, executed as below.

ROM capacity of 16KB: transferred addresses C000 to FFFFH to addresses 4000 to 7FFFH

iii) Writing address is specified. (note 1)-

Start address: 4000H End address: 7FFFH

(4) Writing

Writing/Verifying is required to be executed in accordance with PROM programmer operating procedure.

- Note 1: The specifying method is referred to the PROM programmer description. The data in addresses 0000 to 3FFFH must be specified to FFH.
- Note 2: When MCU is set to an adapter or the adapter is set to PROM programmer, a position of pin 1 must be adjusted. If the setting is reversed, MCU, the adapter and PROM program is damaged.
- Note 3: TMP87PH46 does not support the electric signature mode (hereinafter referred to as "signature"). If the signature is used in PROM program, a device is damaged due to applying $12V \pm 0.5 V$ to the address pin 9 (A9). The signature must not be used.



Electrical Characteristics

Absolute Maximum Ratings (V_{SS} = 0V)

Parameter	Symbol	Conditions	Ratings	Unit
Supply Voltage	V_{DD}		- 0.3 to 6.5	V
Input Voltage	V_{IN}		- 0.3 to V _{DD} + 0.3	٧
Output Voltage	V _{OUT1}	Except sink open drain pin , but include R2 and RESET Sink open drain pin except port P2, RESET	0.3 to V _{DD} + 0.3 - 0.3 to V _{DD} + 0.3	V
Output Current (Per 1 pin)	I _{OUT1}	Ports P1, P2, P6, P7 Port P0	3.2	mA
Output Current (Total)	Σ I _{OUT1} Σ I _{OUT2}	Ports P1, P2, P6, P7 Port P0	100	mA
Power Dissipation [Topr = 70°C]	PD	87PH46	600	mW
Soldering Temperature (time)	Tsld		260 (10 s)	°C
Storage Temperature	Tstg		- 55 to 125	°C
Operating Temperature	Topr		- 30 to 70	°C

Note: The absolute maximum ratings are rated values which must not be exceeded during operation, even for an instant. Any one of the ratings must not be exceeded. If any absolute maximum rating is exceeded, a device may break down or its performance may be degraded, causing it to catch fire or explode resulting in injury to the user. Thus, when designing products which include this device, ensure that no absolute maximum rating value will ever be exceeded.

Recommended Operating Conditions

 $(V_{SS} = 0 \text{ V, Topr} = -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Pins	Conditions	Min	Max	Unit
			fc = 8 MHz IDLE1, 2 mode	4.5		
			fc = 4.2 MHz NORMAL1, 2 mode			
Supply Voltage	y _{DD}		IDLE1, 2 mode	2.7	5.5	V
			fs = SLOW mode			
4			32 768 kHz SLEEP mode			
	1		STOP mode	2.0		
	V _{IH1}	Except hysteresis input	V >45V	$V_{DD} \times 0.70$		
Input High Voltage/	V _{IH2}	Hysteresis input	V _{DD} ≧ 4.5 V	$V_{DD} \times 0.75$	V_{DD}	V
\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	V _I J/3	\wedge	V _{DD} <4.5 V	$V_{DD} \times 0.90$		
	V _{IL1}	Except hysteresis input	V >45V		$V_{DD} \times 0.30$	
Input Low Voltage	V _{IL2}	Hysteresis input	V _{DD} ≧ 4.5 V	0	$V_{DD} \times 0.25$	V
	V _{IL3}		V _{DD} <4.5 V		V _{DD} × 0.10	
	fc((VIN YOUT	V _{DD} = 4.5 to 5.5 V		8.0	N/III-
Clock Frequency	ıc \	$V_{DD} = 2.7 \text{ to } 5.5 \text{ V}$		1.0	4.2	MHz
	fs	XTIN, XTOUT		30.0	34.0	kHz

Note 1: The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to

Note 2: Clock frequency fc; Supply voltage range is specified in NORMAL mode and IDLE mode.

D.C. Characteristics

 $(V_{SS} = 0V, Topr = -30 to 70^{\circ}C)$

Parameter	Symbol	PINS	Conditions	Min	Тур.	Max	Unit
Hysteresis Voltage	V _{HS}	Hysteresis inputs	V _{DD} = 5.0 V	1	0.9	_	V
	I _{IN1}	TEST	V _{DD} = 5.5 V) }			
Input Current	I _{IN2}	Open drain ports, Tri-state ports	V _{IN} = 5.5 V / 0 V	<u> </u>	_	± 2	μΑ
	I _{IN3}	RESET, STOP		>			
Input Resistance	R _{IN2}	RESET		100	220	450	kΩ
Output Leakage	I _{LO1}	Sink open drain ports	$V_{DD} = 5.5 \text{ V}, V_{OUT} = 5.5 \text{ V}$	_	7	2	
Current	I _{LO2}	Tri-state ports	$V_{DD} = 5.5 \text{ V}, V_{OUT} = 5.5 \text{ V}/0 \text{ V}$	-0	5	± 2	μΑ
Output High Voltage	V _{OH2}	Tri-state ports	$V_{DD} = 4.5 \text{ V}, I_{QH} = -0.7 \text{ mA}$	4.1		<u> </u>	V
Output Low Voltage	V _{OL}	Except XOUT and P0	$V_{DD} = 4.5 \text{ V}, I_{OL} = 1.6 \text{ mA}$		<u> </u>	0.4	V
Output Low current	I _{OL3}	P0	$V_{OD} = 4.5 \text{ V, } V_{OL} = 1.0 \text{ V}$	$\langle \gamma \rangle$	20	_	mA
Supply Current in NORMAL 1, 2 modes			$V_{DD} = 5.5 \text{ V}$ $V_{NN} = 5.3 \text{ V}/0.2 \text{ V}$)	8	14	mA
Supply Current in IDLE 1, 2 modes			fc = 8MHz fs = 32.768 kHz) –	4	6	mA
Supply Current in NORMAL 1, 2 modes			$V_{DD} = 3.0 \text{ V}$ $V_{IN} = 2.8 \text{ V}/0.2 \text{ V}$	-	2.5	3.5	mA
Supply Current in IDLE 1, 2 modes	I _{DD}		fc = 4.19 MHz fs = 32.768 kHz	_	1.5	2.0	mA
Supply Current in SLOW mode			$V_{DD} = 3.0 \text{ V}$ $V_{IN} = 2.8 \text{ V/0.2 V}$	_	30	60	μΑ
Supply Current in SLEEP mode			fs = 32.768 kHz	_	15	30	μΑ
Supply Current in STOP mode			$V_{DD} = 5.5 V$ $V_{IN} = 5.3 V/0.2 V$	ı	0.5	10	μΑ

Note 1: Typical values show those at Vopr = 25℃.

Note 2: Input Current I_{N1}/I_{N3}, The current through resistor is not included, when the input resistor (pull-up or pull-down) is contained.

A / D Conversion Characteristics

 $(V_{SS} = 0V, V_{DD} = 2.7 \text{ to } 5.5V, \text{Topr} = -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Analog Reference Voltage	V _{AREF}		2.7	_	V _{DD}	V
Analog Reference voltage	VASS		V _{SS}			٧
Analog Input Voltage	VAIN		V _{ASS}	-	V _{AREF}	>
Analog Supply Current	I _{REF}	$V_{AREF} = 5.5 \text{ V}, \ V_{ASS} = 0.0 \text{ V}$	-	0.5	1.0	mA
Nonlinearity Error		V _{DD} = 5.0 V V _{ARFF} = 5.000 V	-	-	± 1	
Zero Point Error		V _{ASS} (V _{SS}) = 0.000 V	-	-	± 1	160
Full Scale Error		$V_{DD} = 2.7 \text{ V}, V_{SS} = 0 \text{ V}$ $V_{ARFF} = 2.700 \text{ V}$	-	_	± 1	LSB
Total Error		V _{ASS} (V _{SS}) = 0.000 V	_	_	± 2	

Note: Quantizing error is not contained in Total Error.

A.C. Characteristics

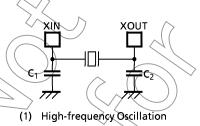
 $(V_{SS} = 0V, V_{DD} = 4.5 \text{ to } 5.5V, Topr = -30 \text{ to } 70^{\circ}\text{C})$

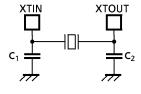
Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
		In NORMAL1, 2 modes	0.5	7	4	
Machine Cycle Time		In IDLE1, 2 modes	0.5		4	
	t _{cy}	In SLOW mode)		μS
		In SLEEP mode	117.6	-	133.3	
High Level Clock Pulse Width	t _{WCH}	For external clock operation	50.5			
Low Level Clock Pulse Width	t _{WCL}	(XIN input), fc = 8 MHz	50.5	7		ns
High Level Clock Pulse Width	t _{WSH}	For external clock operation				
Low Level Clock Pulse Width	t _{WSL}	(XTIN input), fs = 32.768 kHz	14.7	(\bigcirc)	\sim	μS

Recommended Oscillating Conditions

 $(V_{SS} = 0V, V_{DQ} = 4.5 \text{ to } 5.5V, \text{ Topr} = -30 \text{ to } 70^{\circ}\text{C})$

		_ (Recommended		Recommended Condition		
Parameter	Parameter Oscillator	Frequency		zillator	C ₁	C ₂	
		8 MHz	KYOCERA MURATA	KBR8.0M CSA8.00MTz			
	Ceramic Resonator			CSACS8.00MT CSTCS8.00MT	30 pF	30 pF	
High-frequency		4 MHz	KYOCERA MURATA	KBR4.0MS CSAC4.00MGC	·		
				CSA4.00MG			
	Crystal Oscillator	8 MHz	төүөсөм	210B 8.0000	20 pF	20 pF	
		4 MHz	точосом	204B 4.0000	20 01	20 01	
Low-frequency	Crystal Oscillator	32.768 kHz	NDK	MX-38T	15 pF	15 pF	





(2) Low-frequency Oscillation

- Note 1: When used in high electric field such as a picture tube, the package is recommended to be electrically shielded to maintain a regular operation.
- Note 2: The product numbers and specifications of the resonators by Murata Manufacturing Co., Ltd. are subject to change. For up-to-date information, please refer to the following URL:

 http://www.murata.co.jp/search/index.html

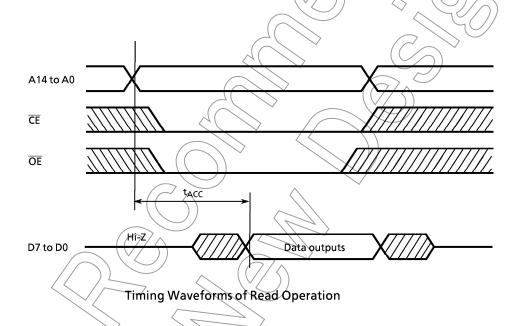
D.C./A.C. Characteristics (PROM mode)

 $(V_{SS} = 0 V)$

(1) READ OPERATION (Topr = $-30 \text{ to } 70^{\circ}\text{C}$)

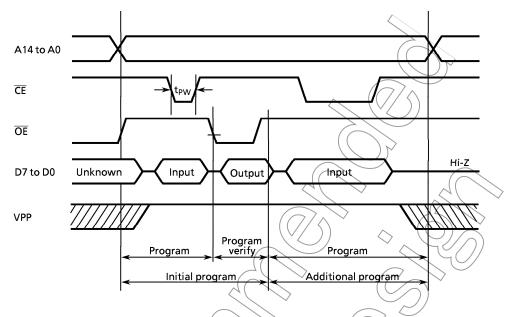
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Input High Voltage	V _{IH4}		V _{CC} × 0.7	(\bigcirc / \bigcirc)	V _{CC}	V
Input Low Voltage	V _{IL4}		0		V _{CC} × 0.12	V
Power Supply Voltage	V _{CC}		4.75) P_	6.0	V
Program Power Supply Voltage	V_{PP}		4.73		0.0	V
Address Access Time	t _{ACC}	V _{CC} = 5.0 ± 0.25 V	4(- //	1.5tcyc + 300	d(-)	ns

Note: tcyc = 500 ns at 8 MHz



(2) Program Operation (High Speed Write Mode \rightarrow I) (Topr = 25 ± 5°C)

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Input High Voltage	V _{1H4}		V _{CC} × 0.7	-	V _{CC}	٧
Input Low Voltage	V _{IL} ₄		0	-	V _{CC} × 0.12	>
Power Supply Voltage	V CC)		5.75	6.0	6.25	٧
Program Power Supply Voltage	V _{PP}		12.0	12.5	13.0	٧
Initial Program Pulse Width	t _{PW}	$V_{CC} = 6.0 \text{ V} \pm 0.25 \text{ V},$ $V_{PP} = 12.5 \pm 0.5 \text{ V}$	0.95	1.0	1.05	ms

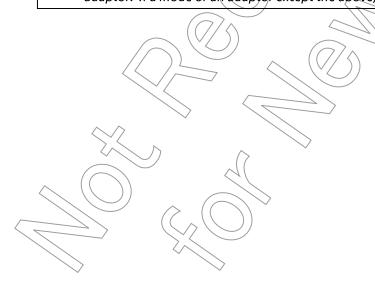


Timing Waveforms of Programming Operation

Note 1: When V_{cc} power supply is turned on or after, V_{pp} must be increased. When V_{cc} power supply is turned off or before, V_{pp} must be decreased.

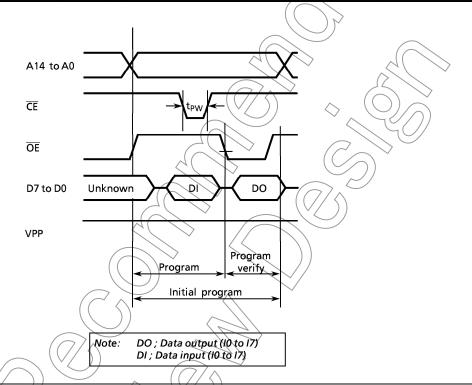
Note 2: The device must not be set to the EPROM programmer or picked up from it under applying the program voltage (12.5 V \pm 0.5 V) to the V_{pp} pin as the device is damaged.

Note 3:Be sure to execute the recommended programing mode with the recommended programing adaptor. If a mode or an adaptor except the above, the misoperation sometimes occurs.



(3) Program Operation (High speed write mode -II) (Topr = 25 ± 5 °C)

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Input High Voltage	V_{IH4}		$V_{CC} \times 0.7$	1	V _{CC}	V
Input Low Voltage	V_{IL4}		0	+	$V_{CC} \times 0.12$	٧
Supply Voltage	V_{CC}		6.00	6.25	6.50	٧
Program Supply Voltage	V_{PP}		12.50	(12,75	13.0	٧
Initial Program Pulse Width	t _{PW}	$V_{CC} = 6.25 \text{ V} \pm 0.25 \text{ V},$ $V_{PP} = 12.75 \text{ V} \pm 0.25 \text{ V}$	0.095	0.1	0.105	ms



- Note 1: When Vcc power supply is turned on or after, Vpp must be increased.

 When Vcc power supply is turned off or before, Vpp must be decreased.
- Note 2: The device must not be set to the EPROM programmer or picked up from it under applying the program voltage (12.75 V \pm 0.25 V) to the Vpp pin as the device is damaged.
- Note 3:Be sure to execute the recommended programing mode with the recommended programing adaptor. If a mode or an adaptor except the above, the misoperation sometimes occurs.

Package Dimensions

